

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination SHEN ET AL	
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U.S. PATENT DOCUMENTS

*	Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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FOREIGN PATENT DOCUMENTS

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N	57184028	11-1982	Japan	Matsuoka et al	108/55.3
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